

<b>Search Notes</b> 	Application/Control No.	Applicant(s)/Patent under Reexamination
	10/708,489	CHANG ET AL.
	Examiner	Art Unit
	Y. J. Han	2838

# SEARCHED

Class	Subclass	Date	Examiner
323	312		
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327	530		
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Search	updated	12/21/2006	jh

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner